Notice of References Cited

Application/Control No. 10/629,924	Reexamination	Applicant(s)/Patent Under Reexamination BOTZEL ET AL.		
Examiner	Art Unit			
Kiet Doan	2683	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,603,979 B1	08-2003	Hirsch, Olaf Josef	455/502
	В	US-6,219,539 B1	04-2001	Basu et al.	455/417
	С	US-6,177,906 B1	01-2001	Petrus, Paul	342/378
	D	US-6,795,413 B1	09-2004	Uhlik, Christopher Richard	370/330
	Ε	US-6,931,030 B1	08-2005	Dogan, Mithat C.	370/509
	F	US-6,466,569 B1	10-2002	Wright et al.	370/347
	G	US-6,061,389 A	05-2000	Ishifuji et al.	375/133
	Н	US-5,506,863 A	04-1996	Meidan et al.	375/134
	ı	US-6,859,486 B1	02-2005	Mohebbi, Behzad	375/132
	J	US-6,549,784 B1	04-2003	Kostic et al.	455/501
	к	US-6,381,231 B1	04-2002	Silventoinen et al.	370/332
	L	US-5,638,361	06-1997	Ohlson et al.	370/342
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.